Se	arcn	Note	es	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/695,405	DIAB, MOHAMED K.	
Examiner	Art Unit	_
Eric F. Winakur	3736	

	SEAR	CHED	
Class	Subclass	Date	Examiner
600	310, 316, 322, 323, 336	7/18/2005	EFW
356	364-368	7/18/2005	EFW
UPDATED	above	3/7/2006	EFW
UPDATED	above	6/26/2006	EFW
	•		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
PGPub	see	6/27/2006	EFW
search	history		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST text search (USPAT; US- PGPub) see search history	7/18/2005	EFW
PALM inventor name search	7/18/2005	EFW
EAST (USPAT; USPGPub) see search history	3/7/2006	EFW